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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: To Be Assigned
Examiner: To Be Assigned

In Re PATENT APPLICATION of:

Applicant(s): Yoshinori SHIZUNO

Serial No.: 10/697,311

Filed: October 31, 2003

For: SEMICONDUCTOR DEVICE WITH IMPROVED
DESIGN FREEDOM OF EXTERNAL TERMINAL

Atty Ref.: OHG 143

INFORMATION
DISCLOSURE
STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(b)(3), i.e., prior to a first Office Action on the merits.

Listed for consideration are two U.S. patents, which also were cited in related co-pending U.S. patent applications, which are listed on the attached Form PTO-1449. Consideration of the listed documents is respectfully requested. The Examiner may also wish to consider related co-pending applications No. 10/697,247, No. 10/722,446 and 10/697,318.

Since this Information Disclosure Statement is being filed before a first Office Action, no certification or fee is required, and the requirements of 37 C.F.R. §§1.97 and 1.98 are deemed to be fully met as to all documents listed. Consideration of the listed documents respectfully is requested.

Should any fee be required, please charge the same to our Deposit Account No. 18-0002 and notify us accordingly.

Respectfully submitted,

Nich Bromer

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January 31, 2005
Date

NSB:dj

FEE ENCLOSED:\$0
Please charge any further
fee to our Deposit Account
No. 18-0002



FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT				Atty. Docket		Application No.	
				OHG 143		10/697,311	
				Applicant Yoshinori SHIZUNO			
				Filing Date October 31, 2003		Group To Be Assigned	
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date
	AA	6,268,648	07/31/01	Fukutomi et al.			
	AB	6,271,469	08/7/01	Ma et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub-Class	Translation
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
OTHER (Including Author, Title, Date, Pertinent Pages, etc.)							
	AO						
Examiner					Date Considered		
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							